

Single N-Channel MOSFET

DESCRIPTION

SMC3206PA is the N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior, fast switching performance and withstand high energy pulse in the avalanche and commutation mode.

PART NUMBER INFORMATION

SMC 3206 PA - TR G
 a b c d e

- a : Company name.
- b : Product Serial number.
- c : Package code PA:DFN5X6A-8
- d : Handling code TR:Tape&Reel
- e : Green produce code G:RoHS Compliant

FEATURES

$V_{DS} = 30V$, $I_D = 90A$

$R_{DS(ON)} = 2.9m\Omega(Typ.)@V_{GS} = 10V$
 $R_{DS(ON)} = 4.1m\Omega(Typ.)@V_{GS} = 4.5V$

- ◆ 100% UIS and Rg tested
- ◆ High power and current handling capability

APPLICATIONS

- ◆ POL Applications
- ◆ DC/DC Converters



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	30	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current	$T_C = 25^\circ C$	90
		$T_C = 100^\circ C$	57.5
I_{DM}	Pulsed Drain Current ^A	200	A
I_D	Continuous Drain Current	$T_A = 25^\circ C$	33
		$T_A = 70^\circ C$	26.5
P_D	Power Dissipation ^B	$T_A = 25^\circ C$	6.3
		$T_A = 70^\circ C$	4
I_{AS}	Avalanche Current ^A	35	A
E_{AS}	Single Pulse Avalanche energy $L=0.1mH$ ^{AF}	61	mJ
P_D	Power Dissipation ^C	$T_C = 25^\circ C$	46
		$T_C = 100^\circ C$	18.2
T_J	Operation Junction Temperature	-55/150	$^\circ C$
T_{STG}	Storage Temperature Range	-55/150	$^\circ C$

THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^B	$t \leq 10s$	20	$^\circ C/W$
	Thermal Resistance Junction to Ambient ^{BD}	Steady-State	50	
$R_{\theta JC}$	Thermal Resistance Junction to Case		2.7	

ELECTRICAL CHARACTERISTICS (T_A = 25°C Unless otherwise noted)

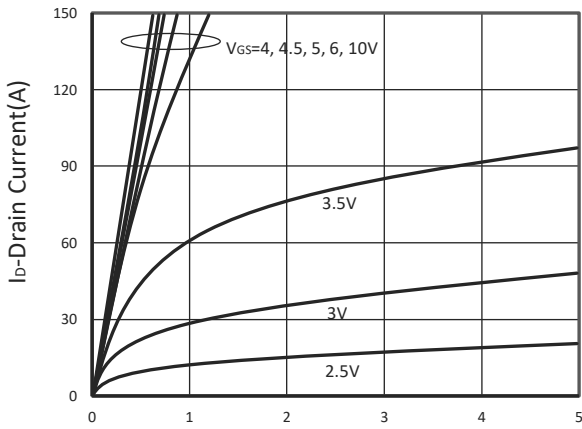
Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Parameters						
B _V DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	30			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.0	1.6	2.5	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V, T _J =25°C			1	μA
		V _{DS} =24V, V _{GS} =0V, T _J =75°C			10	
R _{DS(ON)}	Drain-source On-Resistance ^E	V _{GS} =10V, I _D =20A V _{GS} =4.5V, I _D =15A		2.9 4.1	3.5 5.3	mΩ
G _{fs}	Forward Transconductance	V _{DS} =10V, I _D =10A		30		S
Diode Characteristics						
V _{SD}	Diode Forward Voltage ^E	I _S =1A, V _{GS} =0V			1	V
I _S	Diode Continuous Forward Current [*]				90	A
T _{rr}	Reverse Recovery Time	I _S =20A, di/dt=100A/μs		34		ns
Q _{rr}	Reverse Recovery Charge			25		nC
Dynamic and Switching Parameters						
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =10V, I _D =20A		47.4	66.3	nC
Q _g	Total Gate Charge (4.5V)			23	32.2	
Q _{gs}	Gate-Source Charge			4	5.6	
Q _{gd}	Gate-Drain Charge			5.3	7.4	
C _{iss}	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz		2250		pF
C _{oss}	Output Capacitance			530		
C _{rss}	Reverse Transfer Capacitance			120		
R _g	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		2		Ω
t _{d(on)}	Turn-On Time ^E	V _{DD} =15V, V _{GEN} =10V R _G =3Ω, I _D =10A		12	22	ns
t _r				16	30	
t _{d(off)}	Turn-Off Time ^E			27	51	
t _f				11	21	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

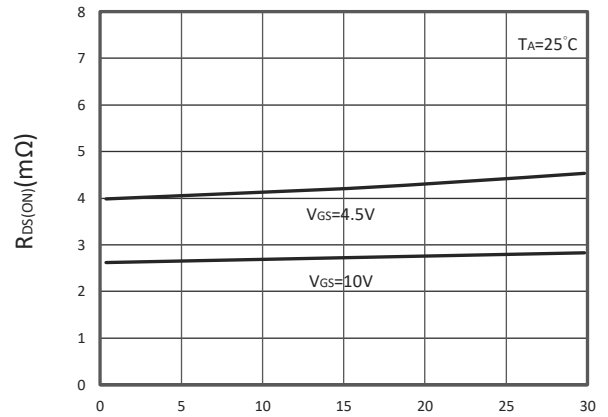
- Pulsed width limited by maximum junction temperature, T_{J(MAX)}=150°C.
- Measure the value in a still air environment at T_A=25°C, using an installation mounted on a 1 in2 FR-4 board, maximum junction temperature T_{J(MAX)}=150°C.
- Using junction-to-case thermal resistance, dissipation limit in the case of additional heat.
- T_{J(MAX)}=150°C, using junction-to-case thermal resistance (R_{θJC}) is more useful in additional heat sinking is used.
- The pulse test width is ≤300μs and the duty cycle ≤ 2%.
- The EAS data shows Maximum, tested and pulse width limited by maximum.

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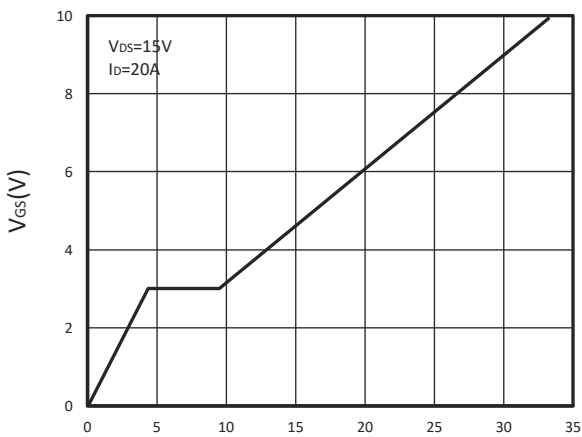
TYPICAL CHARACTERISTICS



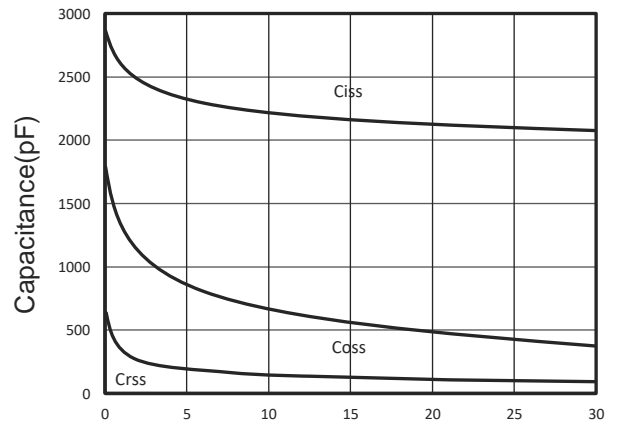
Output Characteristics



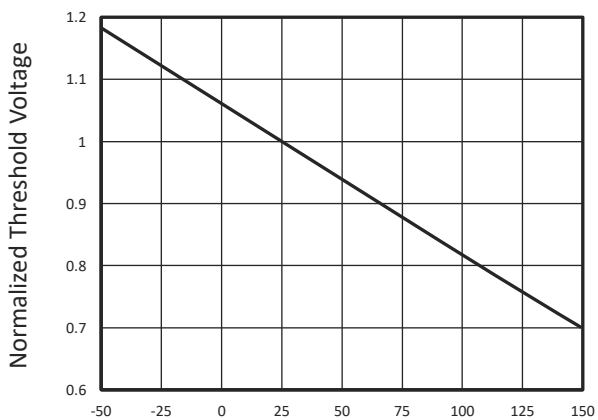
Drain-Source On Resistance



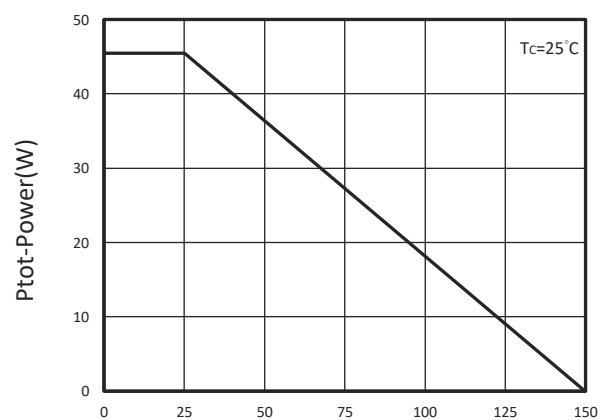
Gate Charge



Capacitance

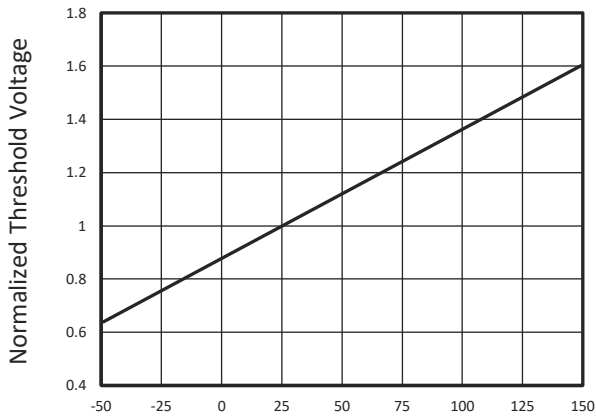


Gate Threshold Voltage

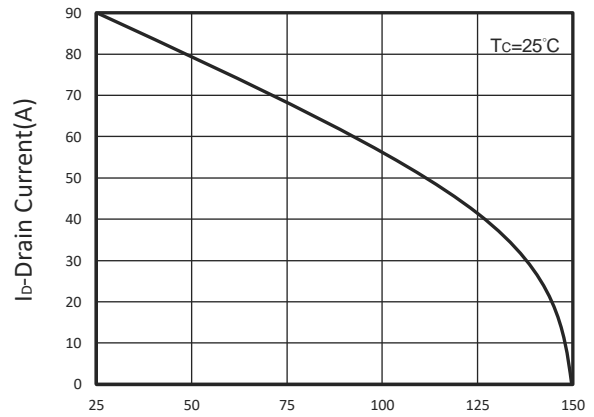


Power Dissipation

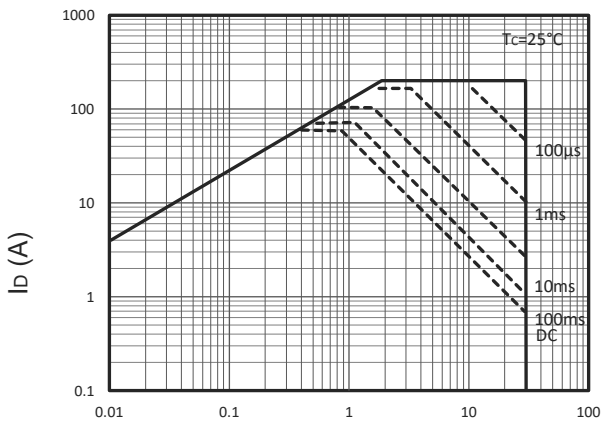
TYPICAL CHARACTERISTICS



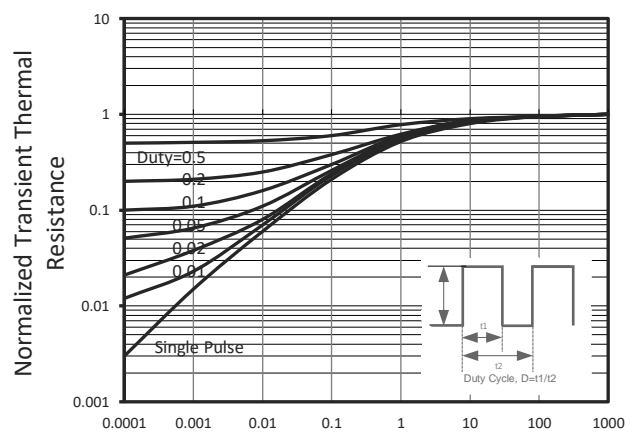
T_J-Junction Temperature(°C)
Gate Threshold Voltage



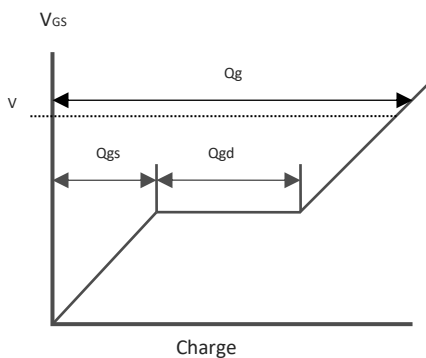
T_C-Case Temperature(°C)
Drain Current vs T_C



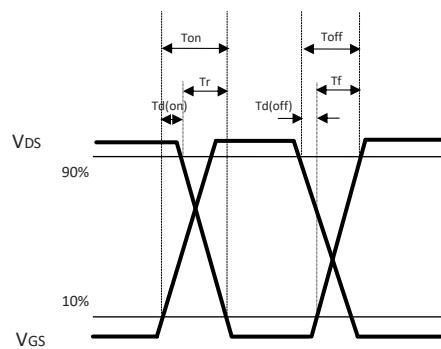
V_{DS} Voltage (V)
Maximum Safe Operation Area



Square Wave Pulse Duration(Sec)
Thermal Transient Impedance

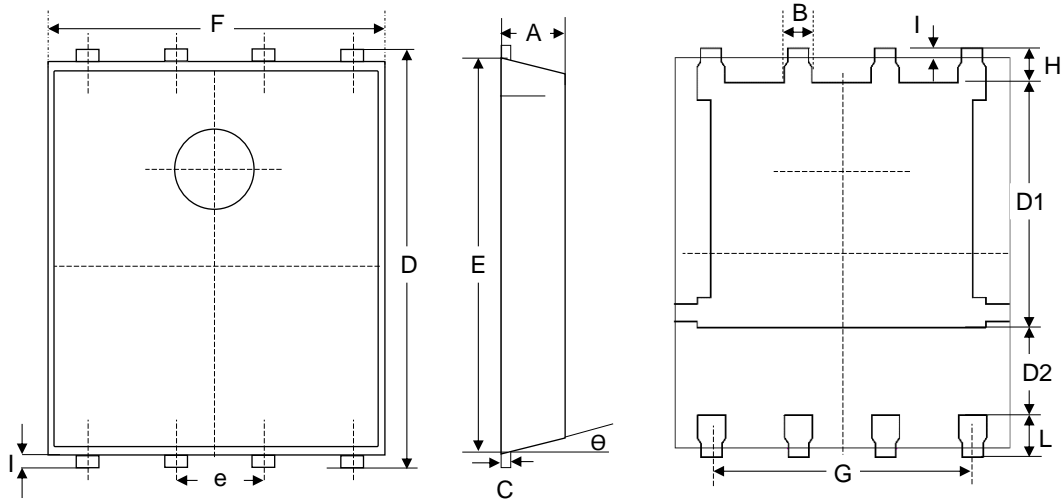


Gate Chrg Waveform



Switching Time Waveform

DFN5X6A PACKAGE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043
B	0.330	0.510	0.013	0.020
C	0.200	0.300	0.008	0.012
D	5.900	6.100	0.232	0.240
D1	3.380	3.780	0.133	0.149
D2	1.100		0.043	
E	5.700	5.800	0.224	0.228
e	1.270BSC.		1.270BSC.	
F	4.800	5.000	0.189	0.197
G	0.361	0.396	0.014	0.016
H	0.410	0.610	0.016	0.024
I	0.060	0.200	0.002	0.008
L	0.510	0.710	0.020	0.028
θ	0°	12°	0°	12°